

# APPROVAL SHEET

# WLPN606010 Series Shielded SMD Power Inductors

\*Contents in this sheet are subject to change without prior notice.

#### Features

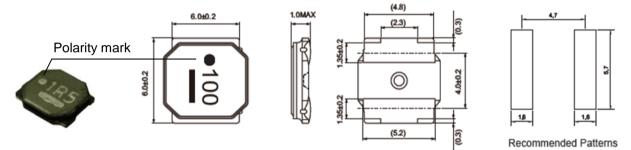
- 1. Close magnetic loop with magnetic resin shielded.
- 2. Low profile, High inductance.

#### Applications

- 1. General propose power inductor in DC power system.
- 2. Inductor in DC/DC converter.
- 3. Low profile for portable and wearable device.
- 4. LC filter in Audio D class Amplifier.

#### Shape and Dimension

Unit: mm



# **Ordering Information**

WL	PN	6060	10	м	1R5	Р	В
Product Code	Series	Dimensions	Thickness	Tolerance	Value	Packing Code	
WL: Inductor	Shielded SMD Power Inductors	6.0 * 6.0 mm	1.0 mm	M: ± 20%	1R5 = 1.5uH 100 = 10uH	P=7" Reeled (Embossed Tape)	B:STD

#### **Electrical Characteristics**

WLPN606010	L (uH)	Inductance Tolerance	Test Freq (KHz)	DCR	SRF	Rated Current (mA) Max	
Series				(Ω ± 30%)	(MHz)Min	Saturation Current Idc1	Temperature Rise Current Idc2
WLPN606010M1R5PB	1.5	М	100	0.090	77	2400	1900
WLPN606010M2R2PB	2.2	М	100	0.110	56	1900	1700
WLPN606010M3R3PB	3.3	М	100	0.135	42	1600	1500
WLPN606010M4R7PB	4.7	М	100	0.165	36	1300	1400
WLPN606010M6R8PB	6.8	М	100	0.220	30	1200	1200
WLPN606010M100PB	10	М	100	0.270	25	1000	1100
WLPN606010M220PB	22	М	100	0.580	12	650	700

1. Test Frequency: 100KHz.

2. Test Equipment:

Inductance: Chroma3302+1320+16502 or equivalent.

DCR: Chroma16502 or equivalent.

SRF: HP4291B or equivalent.

3. Saturation Current Idc1: The value of current causes a 30% inductance reduction from initial value.

4. Temperature rise current Idc2: The value of current causes a 40°C temperature rise.

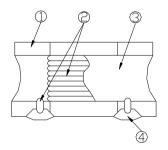
5. Rated Current: Either Idc1 or Idc2 whichever is smaller.

6. Operating Temperature Range:-25 $^\circ\!\mathrm{C}$  to +125 $^\circ\!\mathrm{C}$  (Including self-temperature rise).

7. Storage Temp. Range :  $-40^{\circ}$ C to  $+85^{\circ}$ C.

8. MSL : Level 1.

#### **Structural Drawing**

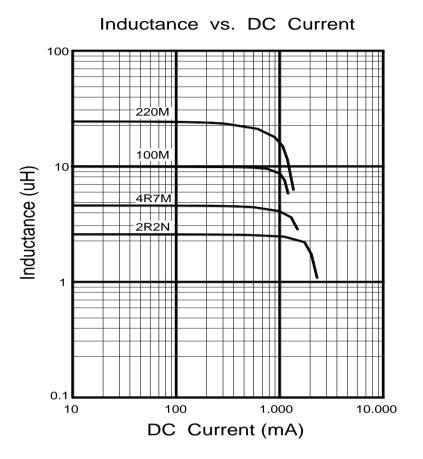


- ① Ferrite core : Ni-Zn ferrite.
- ② Winding wire : Polyurethane-copper wire.
- ③ Over-coating resin : Epoxy resin, containing ferrite powder.
- Electrode : External electrode (substrate)
   Ag
  - External electrode (base plating) Ni-Sn

External electrode (top surface solder coating) Sn-Ag-Cu

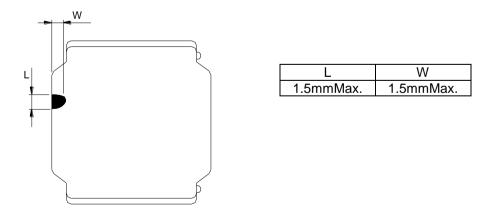


#### **Characteristic Curve**



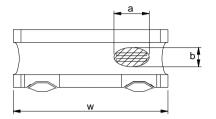
#### **Core Chipping:**

The appearance standard of the chipping size in top side, of bottom side ferrite core is following dimension.



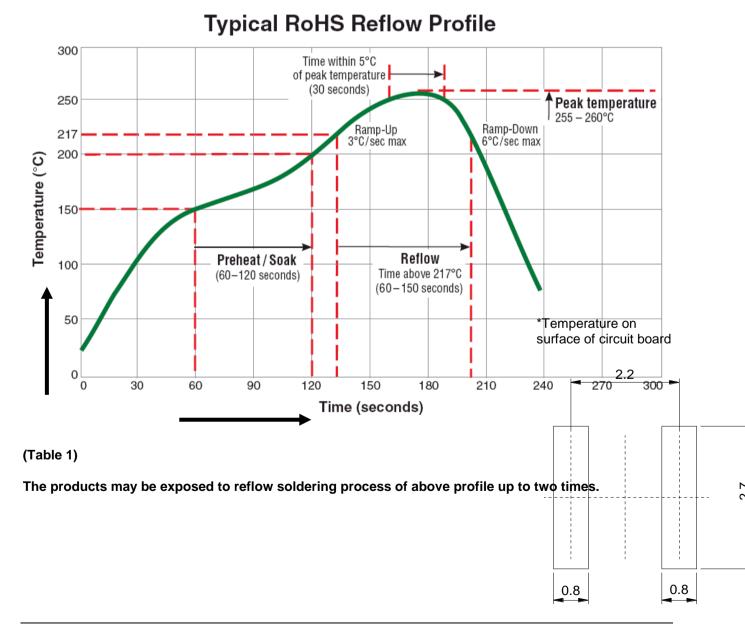


# Exposed wire tolerance limit of coating resin part on product side Size of exposed wire occurring to coating resin is specified below.



- Width direction (dimension a): Acceptable when a<=w/2 Nonconforming when a>w/2
   Length direction (dimension b): Dimension b is not specified.
- ③ When total area of exposed wire occurring to each sides is not greater than 50% of coating resin area, that is acceptable.

## **Reflow Profile Chart (Reference):**



#### Mechanical Performance /Environmental Test Performance Specifications: (WLPN606010 series)

No.	ltem	Test condition	Requirements						
	Resistance to Deflection.	No damage.	The test samples shall be soldered to the test board by the reflow soldering conditions show in Table 1. As illustrated below, apply force in the direction of the Arrow indicating until deflection of the test board Reaches to 2 mm.						
1			R5 $45\pm2$ $45\pm2$ $0.8$ $1.4$ $0.8$						
			Land dimensionsTest board size :100x40x10Unit: mmTest board material I: glass epoxy-resinSolder cream thickness:0.1						
	Adhesion of Terminal Electrode.	Shall not come off PC board	The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1.						
2			□ → 10 N, 5 s Applied force: 10 N to X and Y directions Duration: 5 s. Solder cream thickness:0.1 mm. (Refer to recommended Land Pattern Dimensions Defined in "Precaution")						
	Body strength.	No damage	Applied force :20 N. Duration :10 s.						
3									
	Resistance to Vibration.	△L/L:within±10% No abnormality observed In	The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1.Then it shall be submitted to below test conditions.						
		appearance	Frequency range 10Hz~55Hz						
4			Total Amplitude 1.5mm(May not exceed acceleration 196 m/S2)						
			Sweeping Method 10Hz to 55Hz to 10 Hz for 1 min.						
			Time For 2 hours on each X, Y, and Z axis.						
5	Resistance to Soldering heat (Reflow).	△L/L:within±10% No abnormality observed In appearance	The test sample shall be exposed to reflow oven at 230±5 deg C for 40 seconds, with peak temperature at 260±5 deg C for 5 seconds, 2 times. Test board thickness:1.0 mm						

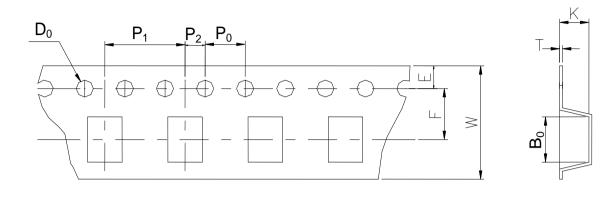
	Solder ability.	At least 90% of surface of terminal electrode is	molten s	t samples shall solder as shown ethanol solution	in below t	able.	hen Immerse	əd in	
6		covered by new solder.		Temperature	245±deg				
		Soluel.	Time		5±1.0 S.	5±1.0 S.			
			Immersing Speed		25 mm/s				
7	Temperature Characteristics.	△L/L:within±20% No abnormality observed In appearance	Measurement of inductance shall be taken at temperature range within -25 deg C to +85 deg C. With reference to inductance value at +20 deg C, change rate shall be calculated.						
	Thermal shock.	△L/L:within±10% No abnormality observed in appearance.	The test samples shall be soldered to test board by the reflow soldering conditions shown in Table 1. The test samples shall be placed at specified shown in below table in sequence. The temperature cycle shall be repeated 100 cycles. Conditions of steps for 1 cycle.						
8				•		Time/m	aia)		
			Step 1	Temperat -40±3 deg		Time(m 30±3			
			2		-				
			3			3 maximum 30±3			
			4				3 maximum		
9	Low Temperature life Test.	△L/L:within±10% No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflowsoldering conditions shown in Table 1.After that, the test samples shall be placed at test conditions as shownin below table.Temperature-40±2 deg CTime500 +24/-0 h						
10	Loading at high temperature life test.	△L/L:within±10% No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1.         The test samples shall be placed in thermostatic oven set at specified temperature and applied the rated current continuously as shown in below table.         Temperature       85±2 deg C         Applied current       Rated current (Refer to Page 3)         Time       500+24/-0 h						
11	Damp heat life test.	△L/L:within±10% No abnormality observed in appearance.	soldering The test		be soldered own in Tab be placed i	d to the test b le 1. in thermostati <u>vn in below ta</u> C RH	c oven set a		
12	Loading under Damp heat life test.	△L/L:within±10% No abnormality observed in appearance.	Time       500+24/-0 ft         The test samples shall be soldered to the test board by the reflow soldering conditions shown in Table 1.         The test samples shall be placed in thermostatic oven set at specified temperature and humidity and applied the rated current continuously as shown in below table.         Temperature       60±2 deg C         Humidity       90~95%RH         Applied current       Rated current (Refer to Page 3)         Time       500+24/-0 h					t specified	

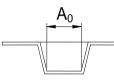
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#### Tape & Reel Packaging Dimensions:

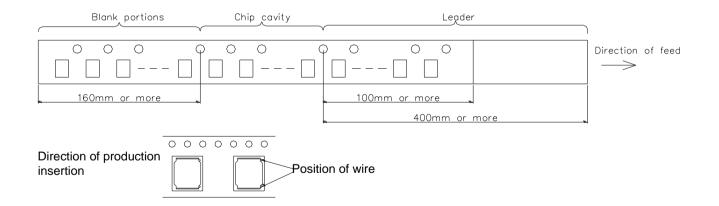
Dimensions Unit: mm





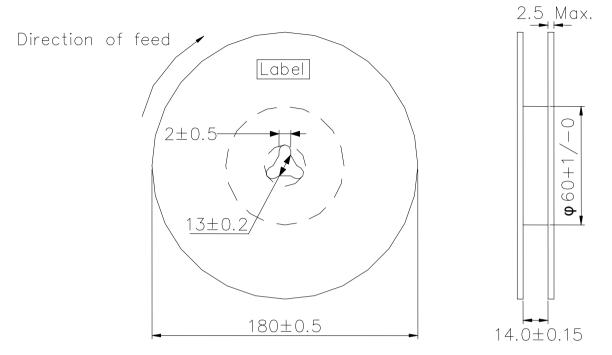
Ao	Bo	W	F	E	<b>P</b> 1	P2	Po	D <sub>0</sub>	Т	K
6.30 ±0.1	6.30 ±0.1	12.0 ±0.3	5.5 ±0.1	1.75 ±0.1	8.0 ±0.1	2.0 土0.1	4.0 ±0.1	Ф1.5 +0.1 -0	0.40 ±0.05	1.40 ±0.1

## **Direction of rolling**



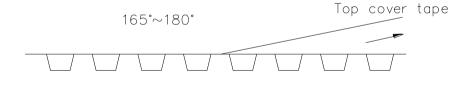


#### Reel



Label position:on the opposite sie of sprocket holes side of reel

## Top tape strength



Peel-off strength: 0.1N~1.3N Peel-off angle:165°~180° Peel-off speed: 300mm/mm

Quantity per reel : 1K pcs